

Search Notes				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/644,182		BUECHLER, JAMES G.	
				Examiner		Art Unit	
				José V. Chen		3637	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner	DATE	EXMR		
108	180	6/16/05	JRC	6/16/05	JRC		
105							
180							
187							
190							
143							
153.1							
155							
157.18							
158.12							
312	257.1						
265.1							
265.2							
195							
280	180						
108.1							
JRC	6/16/05	JRC					
JRC	6/16/05	JRC					
JRC	6/16/05	JRC					
INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
108	180	6/16/05	JRC				
158.12							